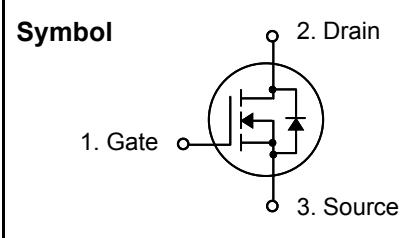


## Logic N-Channel MOSFET

### Features

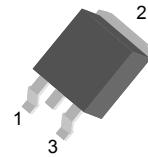
- Low  $R_{DS(on)}$  (0.019Ω) @  $V_{GS}=10V$
- Low Gate Charge (Typical 21.5nC)
- Low  $C_{RSS}$  (Typical 130pF)
- Improved dv/dt Capability
- 100% Avalanche Tested
- Maximum Junction Temperature Range (150°C)



### General Description

This Power MOSFET is produced using SemiWell's advanced planar stripe, DMOS technology. This latest technology has been especially designed to minimize on-state resistance, have a low gate charge with superior switching performance and rugged avalanche characteristics. This Power MOSFET is well suited for synchronous DC-DC Converters and Power Management in portable and battery operated products.

**D-PACK (TO-252)**



### Absolute Maximum Ratings

| Symbol         | Parameter   | Value      | Units |
|----------------|---|------------|-------|
| $V_{DSS}$      | Drain to Source Voltage   | 30         | V     |
| $I_D$          | Continuous Drain Current(@ $T_C = 25^\circ C$ )                                 | 40.3       | A     |
|                | Continuous Drain Current(@ $T_C = 100^\circ C$ )                                | 25.5       | A     |
| $I_{DM}$       | Drain Current Pulsed  | (Note 1)   | A     |
| $V_{GS}$       | Gate to Source Voltage  | $\pm 20$   | V     |
| $E_{AS}$       | Single Pulsed Avalanche Energy  | (Note 2)   | mJ    |
| $dv/dt$        | Peak Diode Recovery $dv/dt$   | (Note 3)   | V/ns  |
| $P_D$          | Total Power Dissipation(@ $T_A = 25^\circ C$ )                                  | 2.5        | W     |
|                | Total Power Dissipation(@ $T_C = 25^\circ C$ )                                  | 56         | W     |
|                | Derating Factor above 25 °C   | 0.45       | W/°C  |
| $T_{STG}, T_J$ | Operating Junction Temperature & Storage Temperature                            | - 55 ~ 150 | °C    |
| $T_L$          | Maximum Lead Temperature for soldering purpose,<br>1/8 from Case for 5 seconds. | 300        | °C    |

### Thermal Characteristics

| Symbol          | Parameter                                 | Value |      |      | Units |
|-----------------|---|-------|------|------|-------|
|                 |   | Min.  | Typ. | Max. |       |
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case      | -     | -    | 2.25 | °C/W  |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient * | -     | -    | 50   | °C/W  |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient   | -     | -    | 110  | °C/W  |

\* When mounted on the minimum pad size recommended (PCB Mount)

# SFD60N03L

## Electrical Characteristics ( $T_C = 25^\circ C$ unless otherwise noted )

| Symbol                         | Parameter                                 | Test Conditions  | Min    | Typ            | Max            | Units        |
|--------------------------------|---|--|--------|----------------|----------------|--------------|
| <b>Off Characteristics</b>     |   |  |        |                |                |              |
| $BV_{DSS}$                     | Drain-Source Breakdown Voltage            | $V_{GS} = 0V, I_D = 250\mu A$  | 30     | -              | -              | V            |
| $\Delta BV_{DSS}/\Delta T_J$   | Breakdown Voltage Temperature coefficient | $I_D = 250\mu A$ , referenced to $25^\circ C$                                      | -      | 0.02           | -              | $V/^\circ C$ |
| $I_{DSS}$                      | Drain-Source Leakage Current              | $V_{DS} = 30V, V_{GS} = 0V$  | -      | -              | 1              | $\mu A$      |
|                                |   | $V_{DS} = 24V, T_C = 125^\circ C$  | -      | -              | 10             | $\mu A$      |
| $I_{GSS}$                      | Gate-Source Leakage, Forward              | $V_{GS} = 20V, V_{DS} = 0V$  | -      | -              | 100            | nA           |
|                                | Gate-Source Leakage, Reverse              | $V_{GS} = -20V, V_{DS} = 0V$   | -      | -              | -100           | nA           |
| <b>On Characteristics</b>      |   |  |        |                |                |              |
| $V_{GS(th)}$                   | Gate Threshold Voltage                    | $V_{DS} = V_{GS}, I_D = 250\mu A$  | 1.0    | -              | 3.0            | V            |
| $R_{DS(ON)}$                   | Static Drain-Source On-state Resistance   | $V_{GS} = 10V, I_D = 20.2A$<br>$V_{GS} = 5V, I_D = 20.2A$                          | -<br>- | 0.013<br>0.017 | 0.019<br>0.024 | $\Omega$     |
| <b>Dynamic Characteristics</b> |   |  |        |                |                |              |
| $C_{iss}$                      | Input Capacitance                         | $V_{GS} = 0V, V_{DS} = 25V, f = 1MHz$  | -      | 1010           | 1320           | pF           |
| $C_{oss}$                      | Output Capacitance                        |  | -      | 450            | 585            |              |
| $C_{rss}$                      | Reverse Transfer Capacitance              |  | -      | 130            | 170            |              |
| <b>Dynamic Characteristics</b> |   |  |        |                |                |              |
| $t_{d(on)}$                    | Turn-on Delay Time                        | $V_{DD} = 15V, I_D = 30A, R_G = 50\Omega$<br><br><b>* see fig. 13.</b> (Note 4, 5) | -      | 20             | 50             | ns           |
| $t_r$                          | Rise Time                                 |  | -      | 55             | 120            |              |
| $t_{d(off)}$                   | Turn-off Delay Time                       |  | -      | 50             | 110            |              |
| $t_f$                          | Fall Time                                 |  | -      | 75             | 160            |              |
| $Q_g$                          | Total Gate Charge                         | $V_{DS} = 24V, V_{GS} = 5V, I_D = 60A$<br><br><b>* see fig. 12.</b> (Note 4, 5)    | -      | 21.5           | 28             | nC           |
| $Q_{gs}$                       | Gate-Source Charge                        |  | -      | 3.6            | -              |              |
| $Q_{gd}$                       | Gate-Drain Charge(Miller Charge)          |  | -      | 10.7           | -              |              |

## Source-Drain Diode Ratings and Characteristics

| Symbol   | Parameter                 | Test Conditions                                   | Min. | Typ. | Max. | Unit. |
|----------|---------------------------|---|------|------|------|-------|
| $I_S$    | Continuous Source Current | Integral Reverse p-n Junction Diode in the MOSFET | -    | -    | 40.3 | A     |
| $I_{SM}$ | Pulsed Source Current     |   | -    | -    | 161  |       |
| $V_{SD}$ | Diode Forward Voltage     | $I_S = 40.3A, V_{GS} = 0V$                        | -    | -    | 1.5  | V     |
| $t_{rr}$ | Reverse Recovery Time     | $I_S = 60A, V_{GS} = 0V, dI_F/dt = 100A/us$       | -    | 40   | -    | ns    |
| $Q_{rr}$ | Reverse Recovery Charge   |   | -    | 35   | -    | nC    |

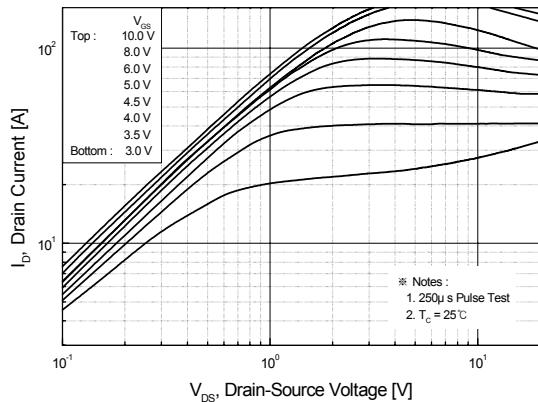
### \* NOTES

1. Repetitive rating : pulse width limited by junction temperature
2.  $L = 165\mu H, I_{AS} = 40.3A, V_{DD} = 15V, R_G = 0\Omega$ , Starting  $T_J = 25^\circ C$
3.  $I_{SD} \leq 60A, di/dt \leq 300A/us, V_{DD} \leq BV_{DSS}$ , Starting  $T_J = 25^\circ C$
4. Pulse Test : Pulse Width  $\leq 300\mu s$ , Duty Cycle  $\leq 2\%$
5. Essentially independent of operating temperature.

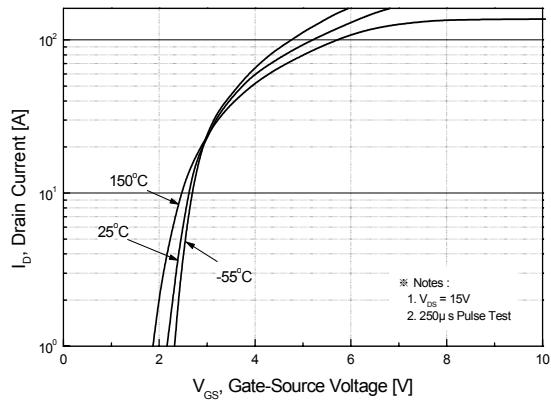


# SFD60N03L

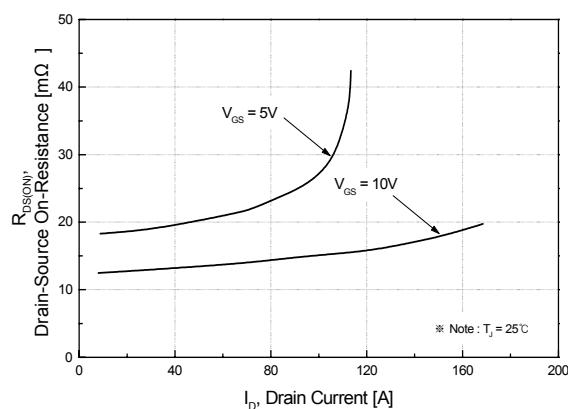
**Fig 1. On-State Characteristics**



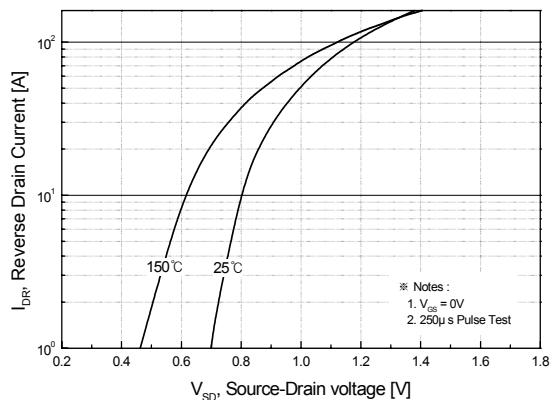
**Fig 2. Transfer Characteristics**



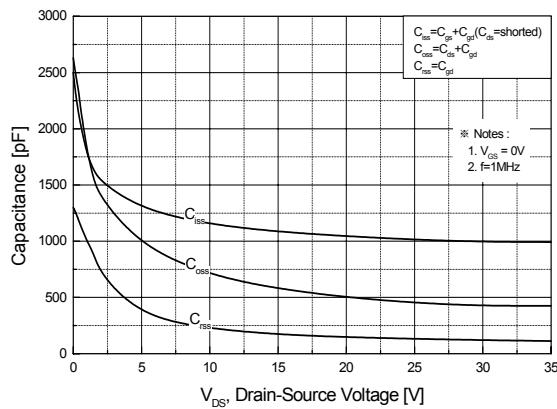
**Fig 3. On Resistance Variation vs. Drain Current and Gate Voltage**



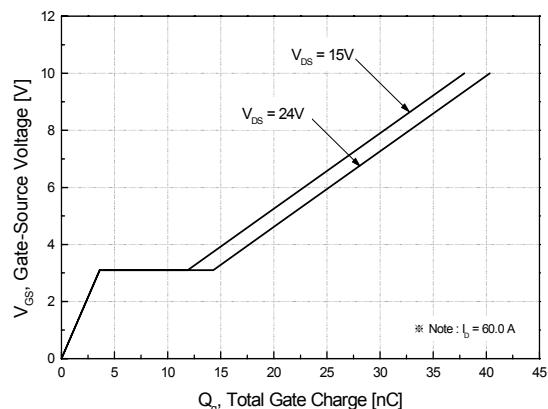
**Fig 4. On State Current vs. Allowable Case Temperature**



**Fig 5. Capacitance Characteristics**

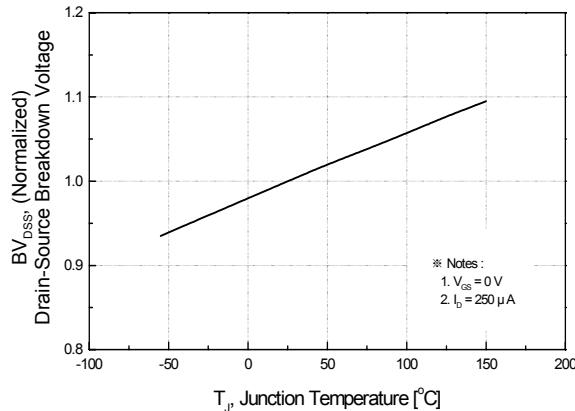


**Fig 6. Gate Charge Characteristics**

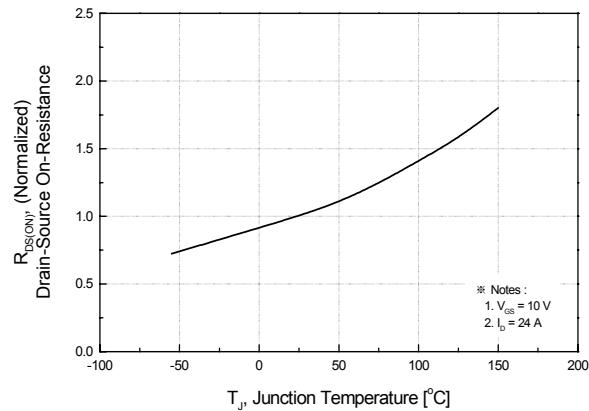


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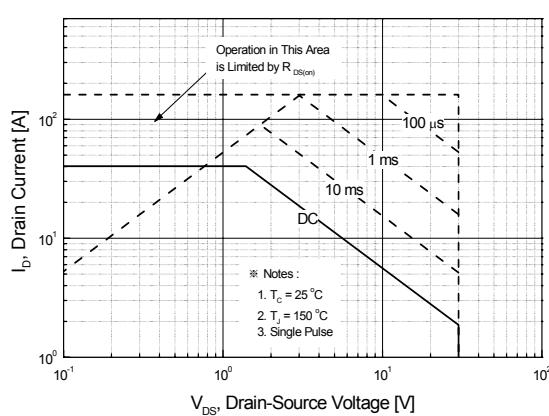
**Fig 7. Breakdown Voltage Variation vs. Junction Temperature**



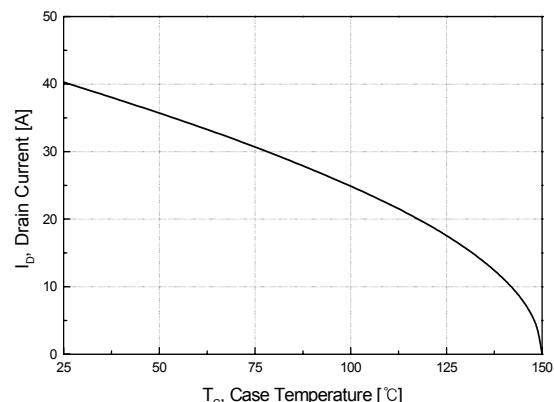
**Fig 8. On-Resistance Variation vs. Junction Temperature**



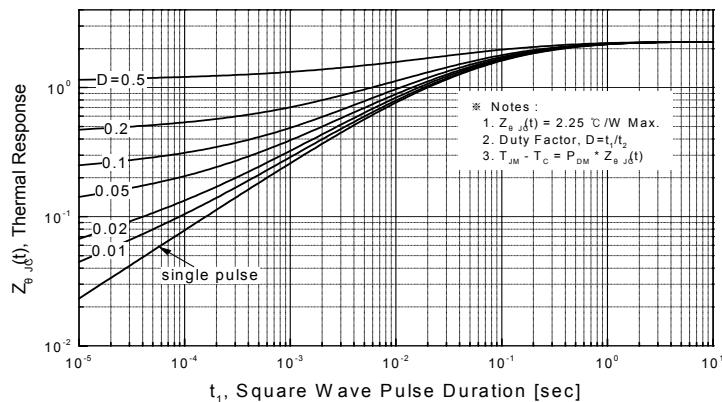
**Fig 9. Maximum Safe Operating Area**



**Fig 10. Maximum Drain Current vs. Case Temperature**



**Fig 11. Transient Thermal Response Curve**



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Fig. 12. Gate Charge Test Circuit & Waveforms

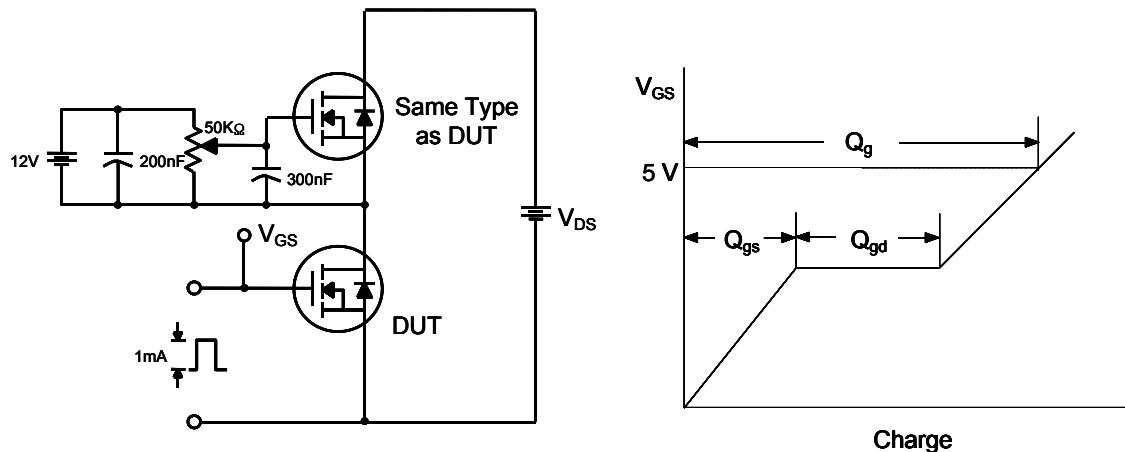


Fig 13. Switching Time Test Circuit & Waveforms

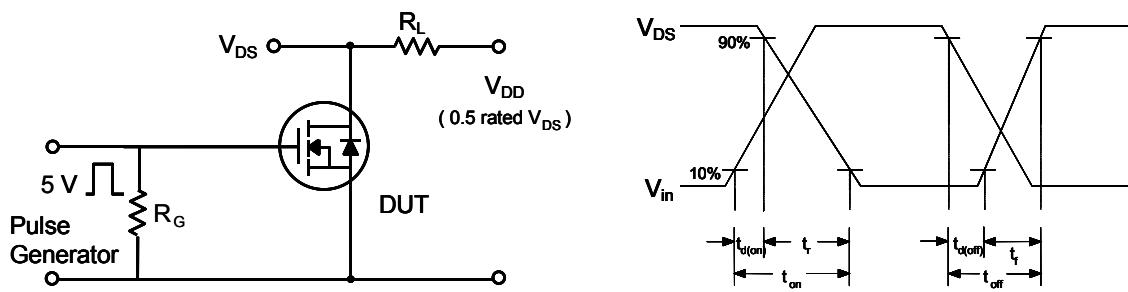
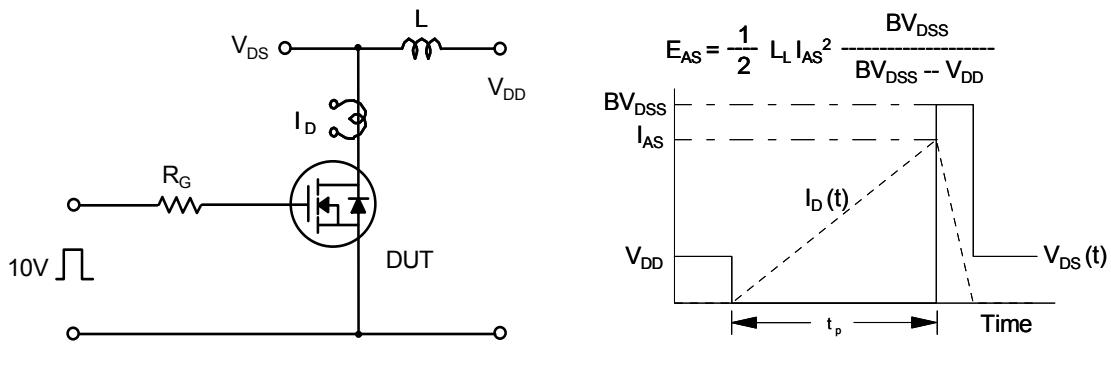
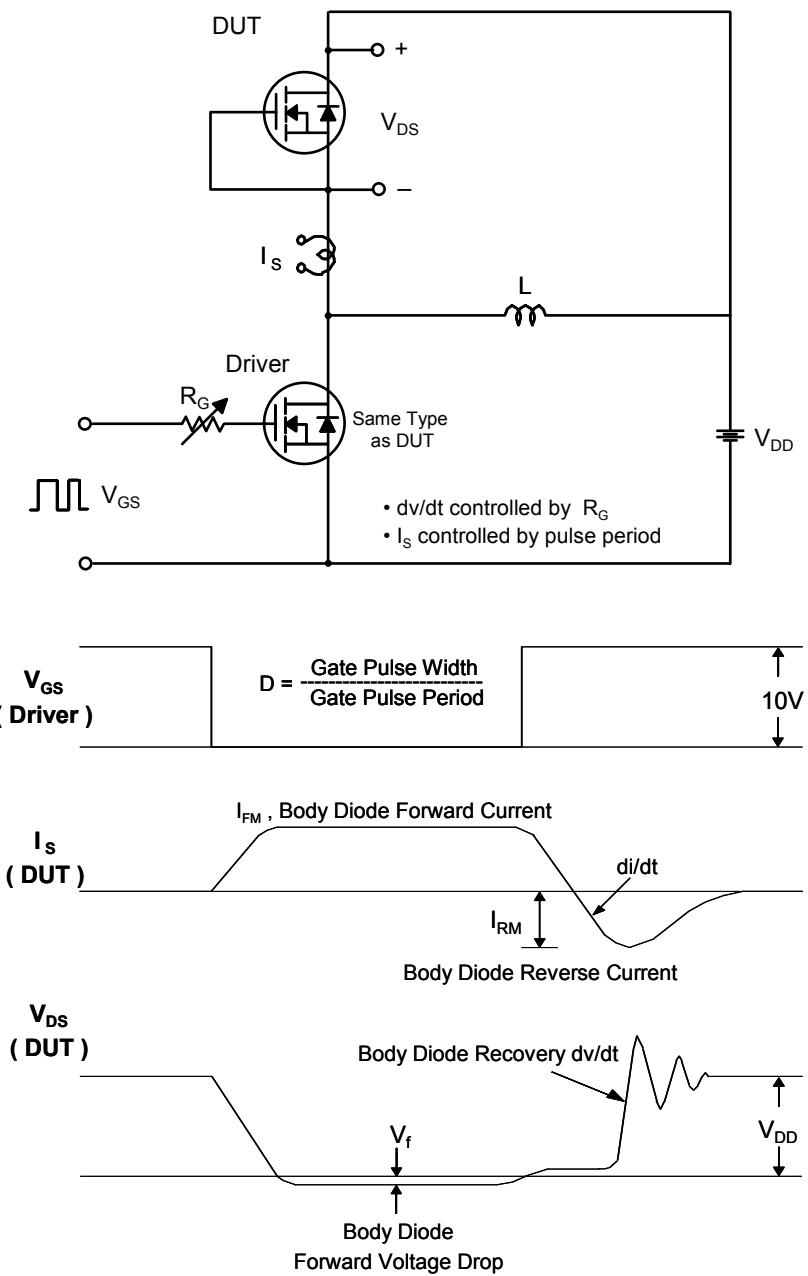


Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms



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Fig. 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms



# SFD60N03L

## TO-252(D-PAK) Package Dimension

| Dim.   | mm    |       |       | Inch  |       |       |
|--------|-------|-------|-------|-------|-------|-------|
|        | Min.  | Typ.  | Max.  | Min.  | Typ.  | Max.  |
| A      | 6.48  | 6.604 | 6.73  | 0.255 | 0.26  | 0.265 |
| B      | 5.0   | 5.08  | 5.21  | 0.197 | 0.2   | 0.205 |
| C      | 7.42  | 7.8   | 8.18  | 0.292 | 0.307 | 0.322 |
| D      | 2.184 | 2.286 | 2.388 | 0.086 | 0.09  | 0.094 |
| E      | 0.762 | 0.813 | 0.864 | 0.03  | 0.032 | 0.034 |
| F      | 1.016 | 1.067 | 1.118 | 0.04  | 0.042 | 0.044 |
| G      |       | 2.286 |       |       | 0.09  |       |
| H      |       | 2.286 |       |       | 0.09  |       |
| I      | 0.534 | 0.61  | 0.686 | 0.021 | 0.024 | 0.027 |
| J      | 1.016 | 1.067 | 1.118 | 0.04  | 0.042 | 0.044 |
| K      |       | 0.508 |       |       | 0.02  |       |
| L      |       | 0.762 |       |       | 0.03  |       |
| $\phi$ |       | 1.57  |       |       | 0.06  |       |

